

| L Number | Hits | Search Text | DB | Time stamp |
|-------------|-------|---|--------------------------------|---------------------|
| - | 1 | "20020099993" | USPAT; US-PGPUB | 2004/05/21 12:11 |
| - | 7 | "015332" | USPAT; EPO; JPO; DERWENT | 2004/05/21 12:14 |
| - | 28 | IKEDA ADJ SATOSHI.in. | USPAT | 2004/05/21 12:40 |
| - | 272 | IKEDA ADJ SATOSHI.in. | USPAT; EPO; JPO; DERWENT | 2004/05/21 12:36 |
| - | 18669 | SONY ADJ CORPORATION.as. | USPAT; EPO; JPO; DERWENT | 2004/05/21 12:40 |
| - | 59 | (SONY ADJ CORPORATION.as.) and test ADJ pattern | USPAT | 2004/05/21 12:42 |
| - | 11 | (SONY ADJ CORPORATION.as.) and test ADJ pattern and semiconductor | USPAT | 2004/05/21 12:46 |
| - | 144 | 714/738.ccls. and test ADJ pattern and semiconductor | USPAT | 2004/05/21 12:48 |
| - | 80 | 714/738.ccls. and test ADJ pattern and semiconductor with device | USPAT | 2004/05/21 12:48 |
| - | 69 | 714/738.ccls. and test ADJ pattern and semiconductor with device and compar\$4 | USPAT | 2004/05/21 12:49 |
| - | 44 | 714/738.ccls. and test ADJ pattern and semiconductor with device and compar\$4 with expected | USPAT | 2004/05/21 12:50 |
| - | 86 | 714/738.ccls. and test ADJ pattern and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:00 |
| - | 45 | 714/738.ccls. and test ADJ pattern ADJ generat\$3 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:04 |
| - | 6 | 714/738.ccls. and test ADJ pattern with vari\$4 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:06 |
| - | 4 | 714/718-739.ccls. and test ADJ pattern with vari\$4 with cycle and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:43 |
| - | 19 | 714/718-739.ccls. and test ADJ pattern with vari\$4 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:16 |
| - | 6 | ("4414665" "4893072" "6219813" "6369601" "6469514" "6479983").PN. | USPAT | 2004/05/21 13:14 |
| - | 3 | ("4414665" "4893072" "6219813" "6369601" "6469514" "6479983").PN. and variable | USPAT | 2004/05/21 13:14 |
| - | 23 | 714/719.ccls. and test ADJ pattern and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:18 |
| - | 1 | 714/719.ccls. and (address with pattern) adj generator and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:21 |
| - | 12 | 714/719.ccls. and (address and pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:26 |
| - | 30 | 714/718-739.ccls. and (address with pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:33 |
| - | 0 | 714/718-739.ccls. and variable near (read or write) adj cycle and test adj pattern and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:35 |
| - | 0 | 714/718-739.ccls. and variable near (read or write) adj cycle | USPAT | 2004/05/21 13:36 |
| - | 5 | 714/718-739.ccls. and variable near (read or write) | USPAT | 2004/05/21 13:36 |
| - | 1 | 714/718-739.ccls. and variable near execution | USPAT | 2004/05/21 13:39 |

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|---|-----|--|-------|---------------------|
| - | 14 | 714/718-739.ccls. and variable near rate | USPAT | 2004/05/21 13:40 |
| - | 2 | 714/718-739.ccls. and adjustable near rate | USPAT | 2004/05/21 13:41 |
| - | 295 | 714/718-739.ccls. and clock near rate | USPAT | 2004/05/21 13:42 |
| - | 3 | 714/718-739.ccls. and clock near modulat\$4 | USPAT | 2004/05/21 13:42 |
| - | 16 | 714/718-739.ccls. and test ADJ pattern and clock adj rate and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/21 13:43 |
| - | 2 | ("6115833" "6243841").PN. | USPAT | 2004/05/21 14:32 |
| - | 67 | 714/718-739.ccls. and (address and pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected | USPAT | 2004/05/24 10:07 |